

# FDMC2523P

## P-Channel QFET®

-150V, -3A, 1.5Ω

### Features

- Max  $r_{DS(on)} = 1.5\Omega$  at  $V_{GS} = -10V$ ,  $I_D = -1.5A$
- Low  $C_{rss}$  ( typical 10pF)
- Fast Switching
- Low gate charge ( typical 6.2 nC )
- Improved  $dv / dt$  capability
- RoHS Compliant

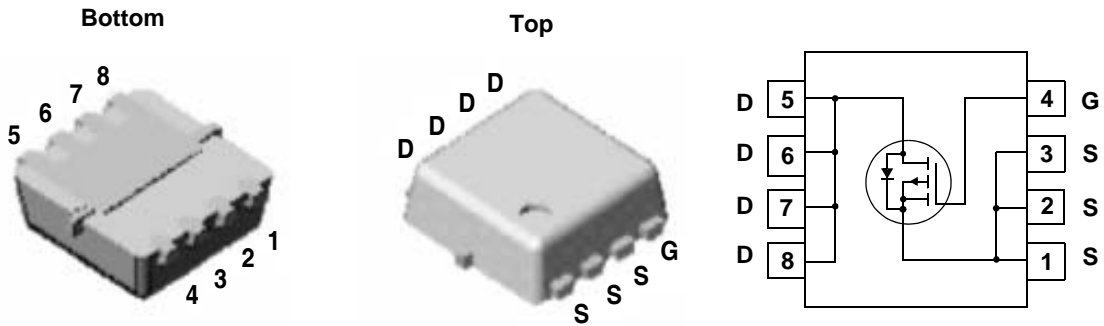


### General Description

These P-Channel MOSFET enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

### Application

- Active Clamp Switch



Power 33

### MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-150	V
$V_{GS}$	Gate to Source Voltage	$\pm 30$	V
$I_D$	Drain Current -Continuous $T_C = 25^\circ\text{C}$	-3	A
	-Continuous $T_C = 100^\circ\text{C}$	-1.8	
	-Pulsed	-12	
$P_D$	Power Dissipation (Steady State) $T_C = 25^\circ\text{C}$	42	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$
$dv/dt$	Peak Diode Recovery $dv/dt$ (Note 2)	-5	V/ns

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	3.0	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC2523P	FDMC2523P	Power 33	7"	8mm	3000 units

## Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	-150			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$		-138		$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -150\text{V}, V_{GS} = 0\text{V}$ $T_J = 125^\circ\text{C}$			-1 -10	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$			$\pm 100$	nA

### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-3	-3.8	-5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$		6		$\text{mV}/^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -10\text{V}, I_D = -1.5\text{A}$ $V_{GS} = -10\text{V}, I_D = -1.5\text{A}, T_J = 125^\circ\text{C}$		1.1 2.0	1.5 3.6	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = -40\text{V}, I_D = -1.5\text{A}$ (Note 4)		1.4		S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = -25\text{V}, V_{GS} = 0\text{V},$ $f = 1\text{MHz}$		200	270	pF
$C_{oss}$	Output Capacitance			60	80	pF
$C_{rss}$	Reverse Transfer Capacitance			10	15	pF
$R_g$	Gate Resistance	$f = 1\text{MHz}$		7.5		$\Omega$

### Switching Characteristics

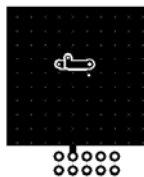
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -75\text{V}, I_D = -3\text{A}$ $V_{GS} = -10\text{V}, R_{GEN} = 25\Omega$ (Note 3,4)		15	27	ns
$t_r$	Rise Time			11	20	ns
$t_{d(off)}$	Turn-Off Delay Time			19	35	ns
$t_f$	Fall Time			13	24	ns
$Q_g$	Total Gate Charge	$V_{GS} = -10\text{V}$		6.2	9	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DD} = -75\text{V}$ $I_D = -3\text{A}$		1.4		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	(Note 3,4)		3.3		nC

### Drain-Source Diode Characteristics

$I_S$	Maximum continuous Drain - Source Diode Forward Current				-3	A
$I_{SM}$	Maximum Pulse Drain - Source Diode Forward Current				-12	A
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = -3.0\text{A}$		-1.8	-5	V
$t_{rr}$	Reverse Recovery Time	$I_F = -3.0\text{A}, di/dt = 100\text{A}/\mu\text{s}$		93		ns
$Q_{rr}$	Reverse Recovery Charge	(Note 3)		0.27		nC

#### Notes:

- 1:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $60^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b.  $135^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper

- 2:  $I_{SD} \leq -3\text{A}, di/dt \leq 300\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$   
 3: Pulse Test: Pulse Width  $< 300\mu\text{s}$ , Duty cycle  $< 2.0\%$ .  
 4: Essentially independent of operating temperature.

**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

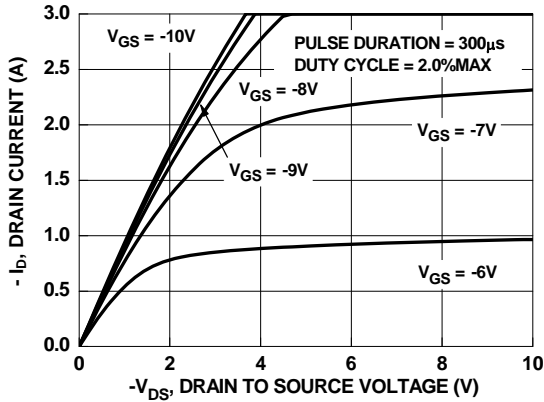


Figure 1. On-Region Characteristics

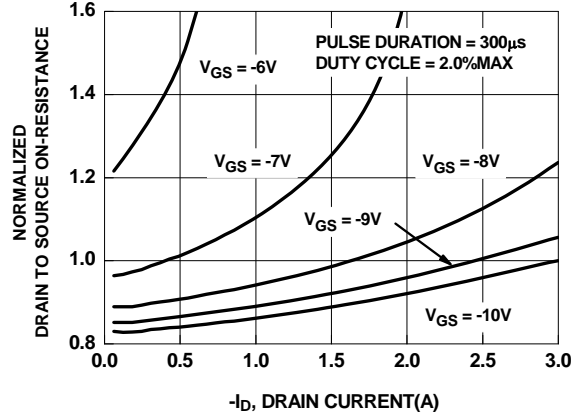


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

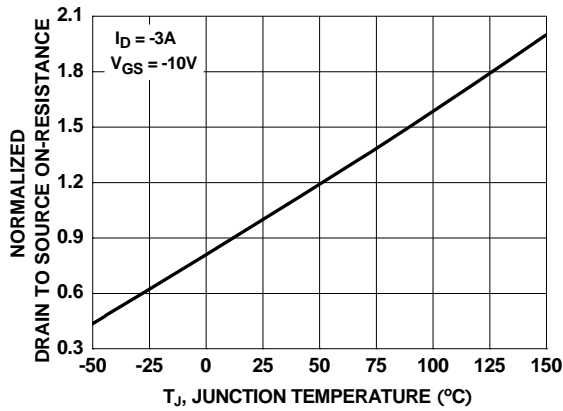


Figure 3. Normalized On-Resistance vs Junction Temperature

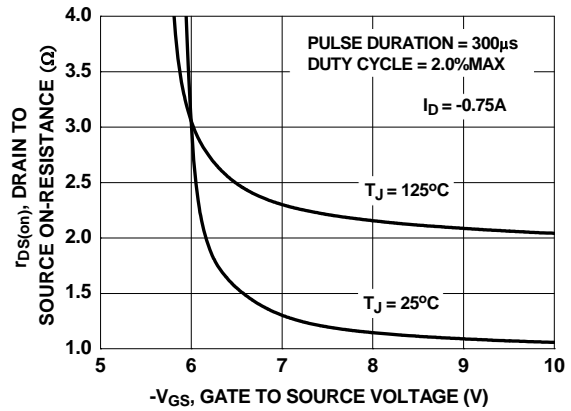


Figure 4. On-Resistance vs Gate to Source Voltage

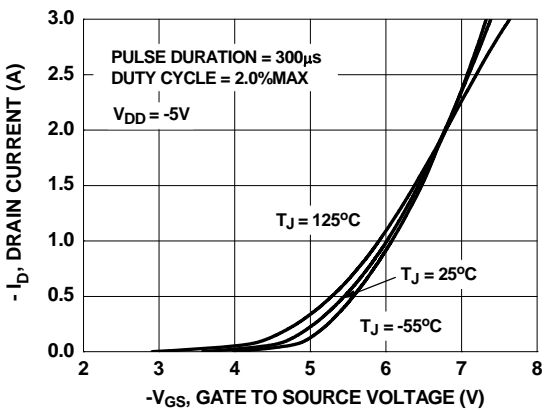


Figure 5. Transfer Characteristics

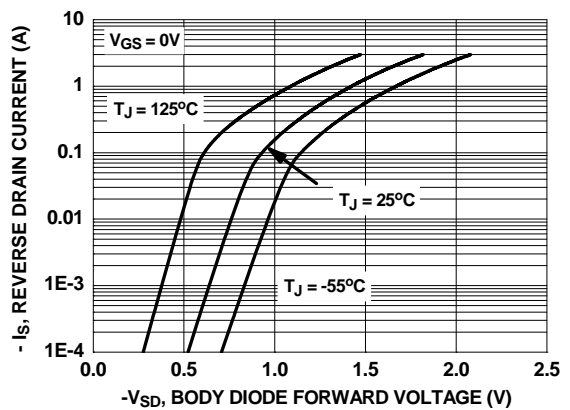
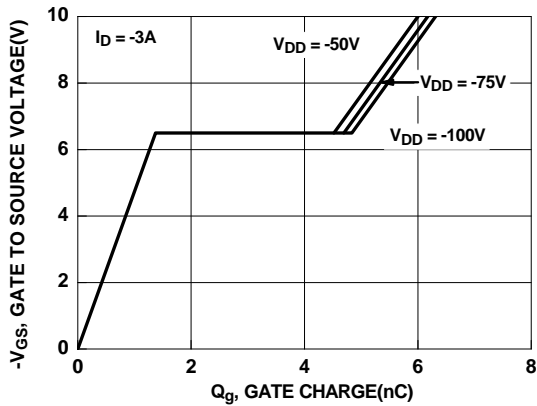
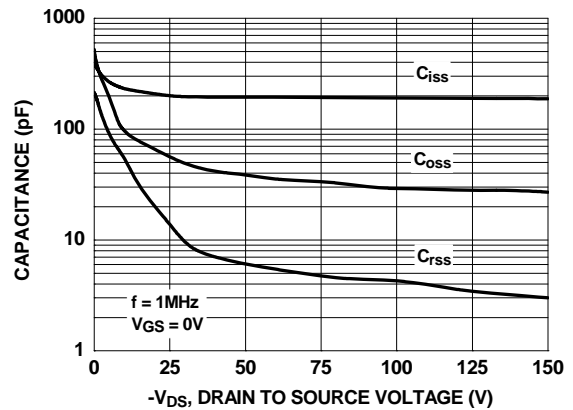


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

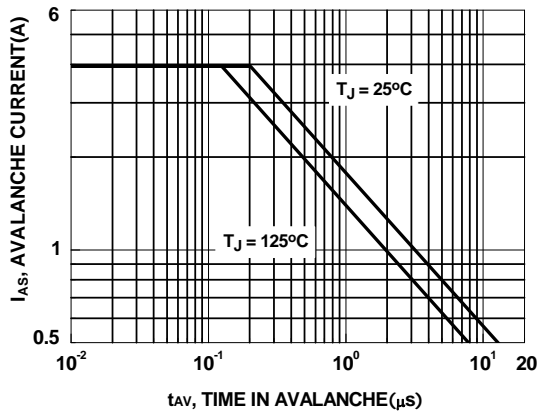
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



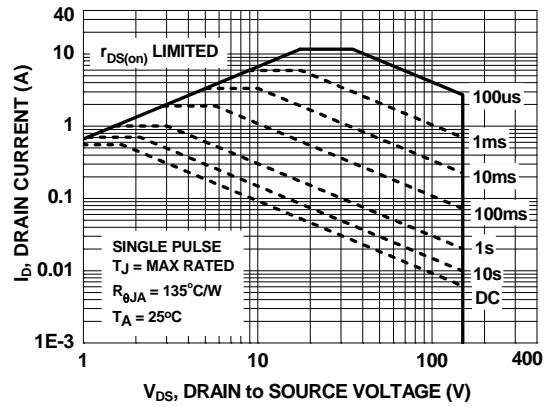
**Figure 7. Gate Charge Characteristics**



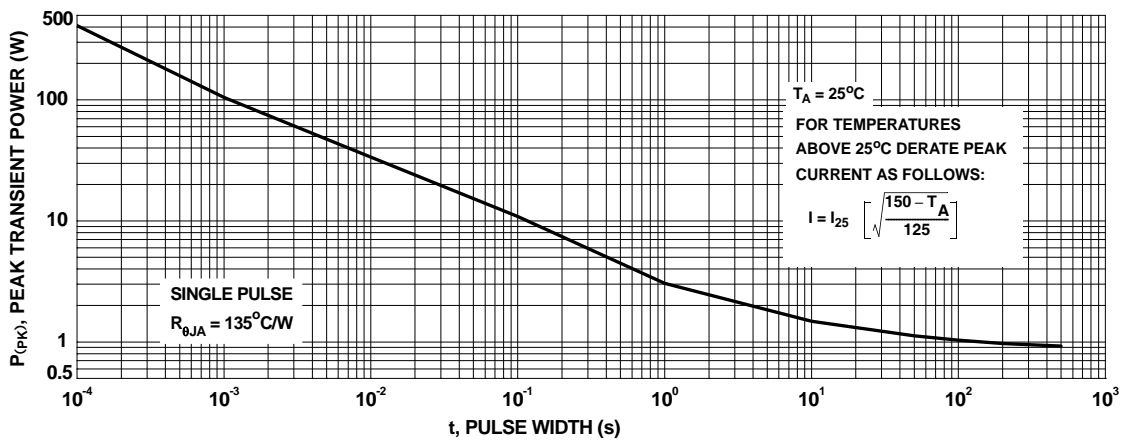
**Figure 8. Capacitance vs Drain to Source Voltage**



**Figure 9. Unclamped Inductive Switching Capability**

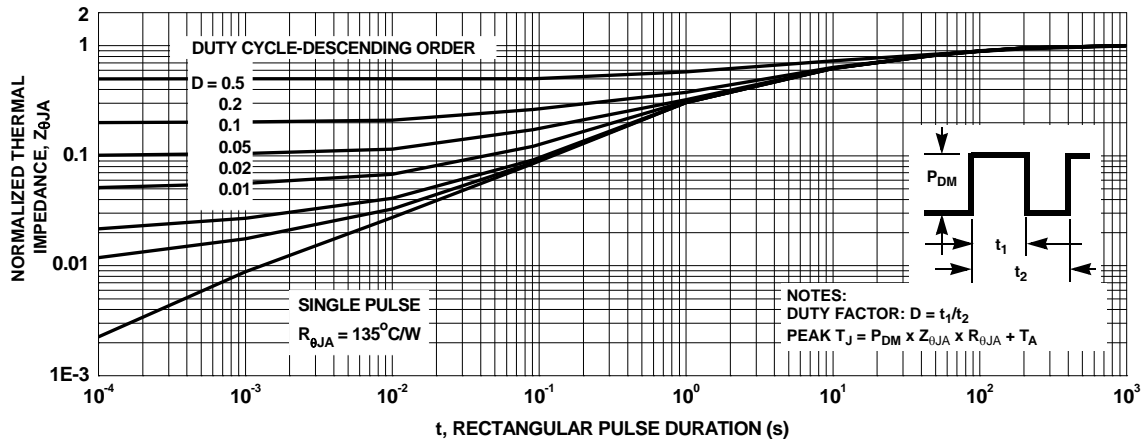


**Figure 10. Forward Bias Safe Operating Area**

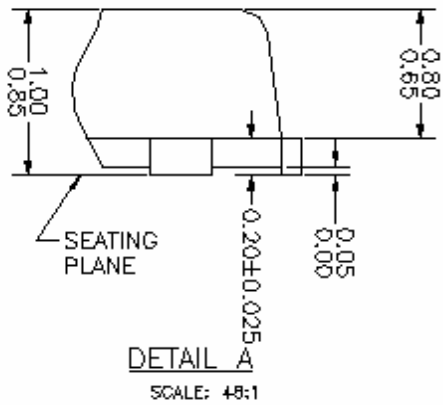
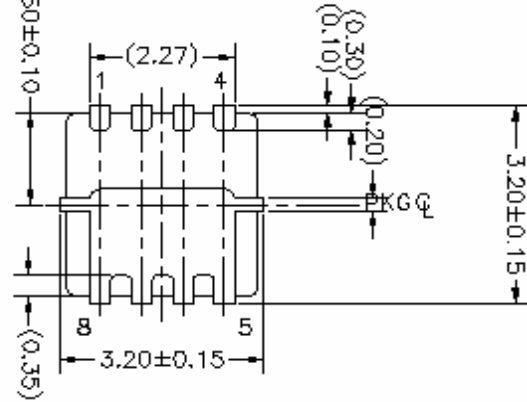
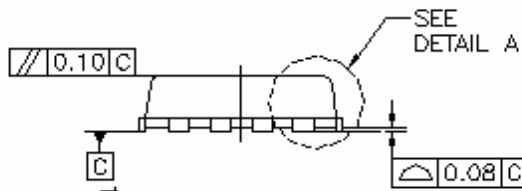
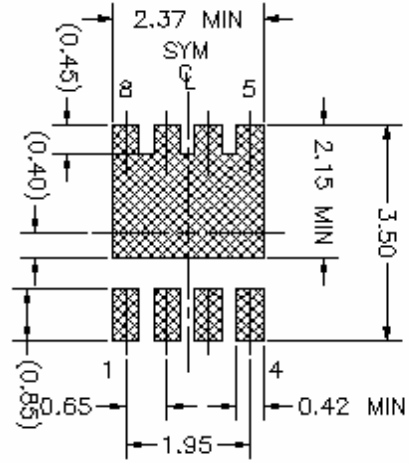
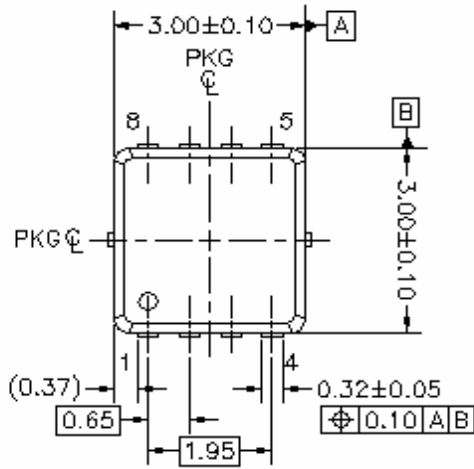


**Figure 11. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



**Figure 12. Transient Thermal Response Curve**



NOTES: UNLESS OTHERWISE SPECIFIED

- A) NO PACKAGE STANDARD REFERENCE AS OF 29 JUNE 2002.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

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